

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10630711	LEE, JU-YUP
	Examiner Tekle, Daniel	Art Unit 2621

SEARCHED

Class	Subclass	Date	Examiner
348	565, 589, 584	06/07/07	D.T.

SEARCH NOTES

Search Notes	Date	Examiner
EAST DATA BASE (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	06/07/07	D.T.
COMBINED CITATION	06/07/07	D.T.
SEARCH QUERY ATTACHED	06/07/07	D.T.
INVENTOR SEARCH	06/01/07	D.T.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner